

Notice of References Cited	Application/Control No. 10/540,220		Applicant(s)/Patent Under Reexamination DISCHAMP ET AL.	
	Examiner DANIEL WALSH		Art Unit 2887	Page 1 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,180,902 A	01-1993	Schick et al.	235/380
*	B	US-5,768,382 A	06-1998	Schneier et al.	380/251
*	C	US-5,796,834 A	08-1998	Whitney et al.	705/60
*	D	US-5,799,086 A	08-1998	Sudia, Frank Wells	705/76
*	E	US-2001/0037454 A1	11-2001	Botti et al.	713/176
*	F	US-2002/0035552 A1	03-2002	Tsubura, Shuichi	705/412
*	G	US-2002/0175211 A1	11-2002	Dominquez et al.	235/492
*	H	US-2003/0005310 A1	01-2003	Shinzaki, Takashi	713/186
*	I	US-2003/0075609 A1	04-2003	Kim, Jin-Soo	235/492
*	J	US-2003/0120615 A1	06-2003	Kuo, James Shaw-Han	705/78
*	K	US-2003/0177347 A1	09-2003	Schneier et al.	713/151
*	L	US-2004/0003255 A1	01-2004	Apvrille et al.	713/178
*	M	US-2004/0049684 A1	03-2004	Nomura et al.	713/182

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/540,220		Applicant(s)/Patent Under Reexamination DISCHAMP ET AL.	
	Examiner DANIEL WALSH		Art Unit 2887	Page 2 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0172531 A1	09-2004	Little et al.	713/155
*	B	US-2004/0203852 A1	10-2004	Janakiraman, Pradeep	455/456.1
*	C	US-2004/0255119 A1	12-2004	Ukeda et al.	713/169
*	D	US-2005/0021974 A1	01-2005	Anderson, Glen J.	713/178
*	E	US-2005/0135411 A1	06-2005	Sureaud, Jean	370/463
*	F	US-6,915,423 B2	07-2005	Lim et al.	713/158
*	G	US-2005/0185515 A1	08-2005	Berstis et al.	368/204
*	H	US-2005/0187022 A1	08-2005	Walker et al.	463/042
*	I	US-2005/0274797 A1	12-2005	Mollett et al.	235/382
*	J	US-2006/0069939 A1	03-2006	Fredriksson et al.	713/400
*	K	US-2006/0135252 A1	06-2006	Amaitis et al.	463/025
*	L	US-2006/0163369 A1	07-2006	Dischamp et al.	235/492
*	M	US-RE39,644 E	05-2007	Alcorn et al.	380/251

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/540,220		Applicant(s)/Patent Under Reexamination DISCHAMP ET AL.	
	Examiner DANIEL WALSH		Art Unit 2887	Page 3 of 3

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2007/0123243 A1	05-2007	Suito, Akiko	455/419
*	B	US-2007/0201723 A1	08-2007	Ito et al.	382/100
*	C	US-2007/0201721 A1	08-2007	Malone et al.	382/100
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.